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In the Claims:

1. (Currently Amended) ~~A semiconductor IC (integrated circuit) chip. A semiconductor IC (integrated circuit) chip~~ A structure for providing a bond area and a probe area on a semiconductor chip, comprising:

 a metal line;

 an interconnect formed through a dielectric layer connecting to the metal line;

 a bond pad on said semiconductor chip having a first portion disposed over the metal line and the interconnect, and a second portion disposed over the dielectric layer and offset from the metal line;

 the first portion including a bond area for providing an attachment point for a connection; and

 the second portion including a probe area for providing contact with a probe, wherein the bond area is separated from the probe area.

2. (Currently Amended) The semiconductor [[IC]] chip as recited in claim 1, wherein the metal line includes copper.

3. (Currently Amended) The semiconductor [[IC]] chip as recited in claim 1, wherein the bond pad includes aluminum.

4. (Currently Amended) The semiconductor [[IC]] chip as recited in claim 1, further comprising a barrier layer disposed between the interconnect and the metal line to prevent diffusion therebetween.